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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/711,232	09/02/2004	Meir Bartur	ZON1.MB.17	5231
47473 OPTICAL ZO	7590 05/23/2007 NU CORPORATION		EXAMINER LEE, DAVID J	
15028 DELAN				
VAN NUYS, (JA 91411		ART UNIT	PAPER NUMBER
			2613	
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			MAIL DATE	DELIVERY MODE
			05/23/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

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	Application No.	Applicant(s)			
	10/711,232	BARTUR ET AL.			
Office Action Summary	Examiner	Art Unit			
	David Lee	2613	,		
The MAILING DATE of this communicati Period for Reply	on appears on the cover sheet	with the correspondence address	;		
A SHORTENED STATUTORY PERIOD FOR WHICHEVER IS LONGER, FROM THE MAIL! - Extensions of time may be available under the provisions of 37 after SIX (6) MONTHS from the mailing date of this communica - If NO period for reply is specified above, the maximum statutory - Failure to reply within the set or extended period for reply will, be Any reply received by the Office later than three months after the earned patent term adjustment. See 37 CFR 1.704(b).	NG DATE OF THIS COMMUN CFR 1.136(a). In no event, however, may a tion. If period will apply and will expire SIX (6) MO by statute, cause the application to become	IICATION. a reply be timely filed ONTHS from the mailing date of this commun ABANDONED (35 U.S.C. § 133).			
Status					
1)⊠ Responsive to communication(s) filed or	n 02 September 2004.				
· · ·	This action is non-final.		ļ		
3) Since this application is in condition for a		itters, prosecution as to the mer	its is		
closed in accordance with the practice u	nder <i>Ex parte Quayle</i> , 1935 C.	D. 11, 453 O.G. 213.			
Disposition of Claims					
4)⊠ Claim(s) <u>1-15</u> is/are pending in the appli	cation.				
4a) Of the above claim(s) is/are w					
5) Claim(s) is/are allowed.					
6)⊠ Claim(s) <u>1-15</u> is/are rejected.	•				
7) Claim(s) is/are objected to.					
8) Claim(s) are subject to restriction	and/or election requirement.				
Application Papers			•		
9) The specification is objected to by the Ex	caminer.				
10)⊠ The drawing(s) filed on <u>02 September 2004</u> is/are: a) accepted or b) objected to by the Examiner.					
Applicant may not request that any objection	to the drawing(s) be held in abey	ance. See 37 CFR 1.85(a).	•		
Replacement drawing sheet(s) including the	correction is required if the drawir	ig(s) is objected to. See 37 CFR 1.	121(d).		
11)☐ The oath or declaration is objected to by	the Examiner. Note the attach	ed Office Action or form PTO-18	52.		
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for f a) All b) Some * c) None of:	oreign priority under 35 U.S.C.	§ 119(a)-(d) or (f).			
1. Certified copies of the priority doc	uments have been received.				
2. Certified copies of the priority doc	uments have been received in	Application No			
3. Copies of the certified copies of the	ne priority documents have bee	en received in this National Stag	е		
application from the International	Bureau (PCT Rule 17.2(a)).				
* See the attached detailed Office action fo	r a list of the certified copies no	ot received.			
•					
Attachment(s)					
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-90) 		v Summary (PTO-413) o(s)/Mail Date			
3) Information Disclosure Statement(s) (PTO/SB/08)	5) 🔲 Notice o	f Informal Patent Application			
Paper No(s)/Mail Date	6)	 ·	·		

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1-3 and 8-14 are rejected under 35 U.S.C. 102(b) as being anticipated by Dennis et al. (US Patent No. 5,539,560).

Regarding claim 1, Dennis teaches an optical transceiver, comprising: a transmitter comprising a laser diode (diode 16 of fig. 1) and a laser driver providing a drive signal to the laser diode (driver 48 of fig. 1); a receiver comprising a photodiode (photodiode 32 of fig. 1) and signal recovery circuitry (processor 40 of fig. 1); and a microcontroller coupled to the transmitter and receiver (OTDR controller 12 of fig. 1) and providing a modulated power control current to the laser during an impulse test mode to transmit high optical power signal and monitoring received signals to detect reflections (e.g., see col. 4, lines 1-12).

Regarding claim 2, Dennis teaches that the transmitter and receiver are coupled to same fiber (fiber 24 of fig. 1).

Regarding claim 3, Dennis teaches that the modulated power control is controlling a laser driver that has modulation and bias power control inputs and wherein said microcontroller modulates said bias control input during said test mode (see e.g., col. 4, lines 1-8).

Regarding claim 8, Dennis teaches that the impulse test signal comprise a code sequence (see col. 4, lines 1-8: the varying of the light pulses is understood as a code sequence).

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Regarding claim 9, Dennis teaches that the microcontroller is capable to detect the code sequence at the output of the comparator (the microcontroller is capable of detecting any signals reflected from a fiber break).

Regarding claim 10, Dennis teaches a method for detection of high optical reflection in a fiber optic network, comprising: transmitting an impulse test signal by modulating a laser transmitter (diode 14 of fig. 1) using an impulse test transmission mode which is different than a data transmission mode used during normal operating conditions (e.g., see col. 3, lines 64-67); and detecting any received signals modulated using said test transmission mode within a predetermined time period after said transmitting (e.g., see col. 4, lines 8-12).

Regarding claim 11, Dennis teaches that the test transmission mode comprises modulating the laser at a power level above the minimum threshold for normal data transmission (see col. 4, lines 1-8).

Regarding claim 12, Dennis teaches that the test transmission mode comprises modulating the laser at a frequency substantially lower than during normal data transmission (see col. 7, lines 33-51: the test/normal modes operate at 1310/1550 nm; in the illustrate given in col. 4, line 4, the test mode is 1310 nm so the normal mode is set at 1550 nm).

Regarding claim 13, Dennis teaches measuring the time delay for receiving the reflected test pulse and determining the location of the reflection (this is OTDR – note OTDR controller 12 of fig. 1).

Regarding claim 14, Dennis teaches increasing the laser transmitter power during transmission of said short duration test pulse (e.g., see col. 4, lines 1-8).

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Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 4-7 are rejected under 35 U.S.C. 103(a) as being unpatentable over Dennis et al. in view of Kimbrough et al. (US Pub. No. 2002/0063924 A1).

Regarding claim 4, Dennis teaches the limitations of claim 1 but does not expressly disclose that the microcontroller employs a dedicated transistor for direct high current impulse drive of the laser. Kimbrough et al. teaches an optical transceiver comprising a laser diode (86A of fig. 6) which is directly driven by a dedicated transistor for high current impulse drive (80 of fig. 6). It would have been obvious to a skilled artisan at the time of invention to incorporate the transistor of Kimbrough in the transceiver of Dennis in order to increase the response and the accuracy of the laser diode.

Regarding claim 5, Dennis teaches the limitations of claim 1 including an amplifier coupled to the photodiode diode (see fig. 6: amplifier connected to the photodiode 32), wherein the microcontroller monitors the output of the amplifier (controller 12 monitors output through converter 36). Dennis does not expressly disclose that the amplifier is a transimpedance amplifier. However, transimpedance amplifiers are well known in the art. For example, Kimbrough teaches an optical transceiver comprising a photodiode (92 of fig. 6) and a transimpedance amplifier (102 and 104 of fig. 6). It would have been obvious to a skilled artisan at the time of invention to incorporate a transimpedance amplifier in the system of Dennis in

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order to ensure a healthy signal to noise ratio and to increase bandwidth without increasing postequalizer noise levels.

Regarding claim 6, the combined invention of Dennis and Kimbrough teaches a comparator coupled between the output of said transimpedance amplifier and said microcontroller for detecting signals at the output of the transimpedance amplifier (see fig. 6 of Kimbrough: note 106 – to comparator).

Regarding claim 7, the combined invention of Dennis and Kimbrough does not teach that the comparator detection level is controlled during the impulse test mode to be more sensitive than during data transport mode. However, it is well known to increase receiver sensitivity while detecting reflections from fiber breaks. This is done to ensure that all signals, no matter how weak, are all received by the transceiver. It would have been obvious to a skilled artisan at the time of invention to set the receiver sensitivity at a higher level during test mode in order to ensure comprehensive detection of reflected signals.

5. Claim 15 is rejected under 35 U.S.C. 103(a) as being unpatentable over Dennis et al.

Regarding claim 15, Dennis does not expressly disclose increasing the detection sensitivity after the transmission of the said short duration test pulse. However, it is well known to increase receiver sensitivity while detecting reflections from fiber breaks. This is done to ensure that all signals, no matter how weak, are all received by the transceiver. It would have been obvious to a skilled artisan at the time of invention to set the receiver sensitivity at a higher level during test mode in order to ensure comprehensive detection of reflected signals.

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6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to David Lee whose telephone number is (571) 272-2220. The examiner can normally be reached on Monday - Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jason Chan can be reached on (571) 272-3022. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

David Lee Patent Examiner

JASON CHAN
SUPERVISORY PATENT EXAMINER
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